

CLEAN VERSION OF CLAIMS FOR SCANNING PER 37 CFR § 1.121

B1 sub 01
7. An apparatus, comprising:

a static random access memory;

a processor coupled to the static random access memory;

a voltage regulator adapted to provide at least two voltage potential levels to at least a portion of the processor; and

wherein the voltage potential level provided by the voltage regulator is adapted to be adjusted depending on the operational load of the processor.

B2 sub 01
~~9. The apparatus of claim 7, further comprising a state machine responsive to the operational load of the processor.~~

B3 sub 01
12. A method comprising:

determining an application mix of a processor;

determining a frequency at which the processor may operate given the application mix; and

determining a voltage potential level corresponding to the frequency; and providing at least a portion of a processor with the frequency and voltage potential level.

13. The method of claim 12, further comprising changing the frequency and voltage potential level in response to a change in the application mix of the processor.

14. A method of operating a processor, comprising:

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B1
adjusting the voltage potential level provided to at least a portion of the processor based on the application mix executed by the processor.

15. The method of claim 14, further comprising determining an operational frequency based on the application mix executed by the processor.

Sub
D3
17. An article comprising: a storage medium having stored thereon instructions, that, when executed by a computing platform, results in:
adjusting the voltage potential level provided to at least a portion of the computing platform based on the application mix executed by the computing platform.

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18. The article of claim 17, wherein the instructions, when executed, further result in determining a preferred operational frequency based on the application mix executed by the computing platform.

19. The article of claim 17, wherein the instructions, when executed, further result in computing platform executing the application mix at peak performance.

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22. A method comprising operating a core of a device at a voltage independent of a voltage that operates a pad ring of the device.

23. The method of claim 22 further including operating the core at a minimum supported voltage and operating the pad ring at a voltage different from the core.

24. The method of claim 22 further including changing the voltage to the core without changing the voltage to the pad ring.

25. An apparatus, comprising:
a processor;
a voltage regulator adapted to provide at least two voltage potential levels to at least a portion of the processor; and
wherein the voltage potential level provided by the voltage regulator is adapted to be adjusted depending on the operational load of the processor.

26. The apparatus of claim 25, wherein the voltage regulator is further adapted to provide the voltage potential level depending on an operational frequency of the processor.

27. The apparatus of claim 25, further comprising a state machine responsive to an operational load of the processor.

28. The apparatus of claim 25, wherein said processor is adapted to receive a clock signal that is varied in accordance with changes in the operational load of said processor.

29. A method comprising operating a processor core at a first voltage independent of a second voltage that operates a pad ring associated with the processor core, said first voltage being varied in accordance with changes in an operational load of said processor core.

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30. The method of claim 29 further including operating the processor core at a minimum supported voltage and operating the pad ring at a voltage different from the processor core.

31. The method of claim 29 further including changing the first voltage to the processor core without changing the second voltage to the pad ring.
